

FORM HDP-1449 (Based on Form PTO-1449)

ATTORNEY DOCKET NO.

SERIAL NO.

0315-000414/REF

10/678,052

PATENT AND TRADEMARK OFFICE

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Mark Bass et al.

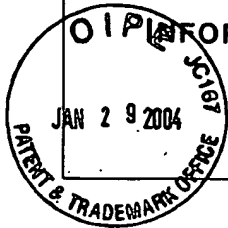
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U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	CqF	4,505,651	3/1985	Terauchi et al.		
2.	CqF	4,575,318	3/1986	Blain		
3.	CqF	4,604,036	8/1986	Sutou et al.		
4.	CqF	4,610,610	9/1986	Blain		
5.	CqF	4,744,733	5/1988	Terauchi et al.		
6.	CqF	4,747,756	5/1988	Sato et al.		
7.	CqF	4,764,096	8/1988	Sawai et al.		
8.	CqF	4,774,816	10/1988	Uchikawa et al.		
9.	CqF	4,846,633	7/1989	Suzuki et al.		
10.	CqF	5,059,098	10/1991	Suzuki et al.		
11.	CqF	5,263,822	11/1993	Fujio		
12.	CqF	5,277,563	1/1994	Weu-Jeu et al.		
13.	CqF	5,282,728	2/1994	Swain		
14.	CqF	5,282,729	2/1994	Swain		
15.	CqF	5,290,161	3/1994	Swain		
16.	CqF	5,336,058	8/1994	Yokoyama		
17.	CqF	5,342,185	8/1994	Anderson		
18.	CqF	5,342,186	8/1994	Swain		
19.	CqF	5,366,359	11/1994	Bookbinder et al.		
20.	CqF	5,366,360	11/1994	Bookbinder et al.		
21.	CqF	5,411,384	5/1995	Bass et al.		

Examiner: Freau

Date Considered: 1/27/07

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22.	CeF	5,435,707	7/1995	Hirano et al.		
23.	CeF	5,447,420	9/1995	Caillat et al.		
24.	CeF	5,520,527	5/1996	Kim		
25.	CeF	5,531,577	7/1996	Hayashe et al.		

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	CeF	DE 34 22 398 A	19.12.1985	Germany			
2.	CeF	WO 86 01262 A	27.02.1986	PCT			
3.	CeF	EP 0 351 690 A1	24.01.1990	EPO			
4.	CeF	EP 0 557 023 A1	25.08.93	EPO			

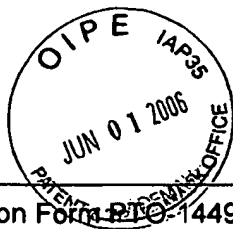
OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	CeF	European Search Report for Application No. EP 95 30 7811; 1 December 1998; 3 Pages.
2.	CeF	English-language Abstract and English-language Summary for Japanese Application No. 59-117895; 8/1984; 5 Pages.
3.	CeF	English-language Abstract for Japanese Publication No. 61046485; 06-03-86; 1 Page.

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FOREIGN PATENT DOCUMENTS

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1.	CeF	JP 55-57683	10-24-1978	Japan			X
2.	CeF	JP 59-117895	01-31-1983	Japan		X	
3.	CeF	JP 60-224987	04-20-1984	Japan			X
4.	CeF	JP 5-187370	07-05-1985	Japan			X
5.	CeF	JP 62-116187	01-13-1986	Japan		X	
6.	CeF	JP 1-240316	03-22-1988	Japan			X
7.	CeF	JP 2-23279	07-12-1988	Japan			X
8.	CeF	JP 6-26470	07-09-1992	Japan			X
9.	CeF	JP 7-12062	06-24-1993	Japan			X
10.	CeF	JP 7-103159	10-05-1993	Japan			X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

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